# LLRF study in cERL



Study at cERL

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## LLRF system

Main function of LLRF systems.

- I. Stabilize the RF field (I&Q Feedback).
- II. Minimize the cavity input power (Tuner Feedback).

Closed-loop operation (Feedback) is required to stabilize the RF field.

Requirement: 0.1% RMS for amplitude and 0.1 deg. RMS for phase [1].





1 .Higher gain (Larger K(s)) corresponds to higher disturbance suppression. However, too high gains may result of unstable.

#### 300 Hz Fluctuation (Inj. 2&3, Buncher)

The 300 Hz fluc. at Inj2&3 (FB2) and Buncher (FB0) cavity during CL/OL operation.
 The Inj1 (FB1) LLRF system doesn't not has evident dominant components.



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#### Fluctuation at 300 Hz (Source)

The Power supply is the probable source of the 300 Hz component.
The RF fluctuation agrees well with the PS fluctuation (suppose 10 deg /HV%, then the 20mV fluctuation in PS will lead to 10 deg × (100 × 25mv/15V) = 1.67 deg ).
According to current controlling parameter (KI=10, KP=0), the 300 Hz component is suppressed by ~10 dB (~3 times), not enough.



## Gain scanning (300 Hz suppression)

- Gain-scanning: Scanning (changing) different proportional gain KP and integral Gain KI (@ 2 MV/m for security) to find out the optimal gains .
- The 300 Hz component is suppressed by high gains.

![](_page_5_Figure_3.jpeg)

#### Suppression of 300 Hz component

![](_page_5_Figure_5.jpeg)

We can also analyze the suppression of the 300 Hz component by simulation, the results agree well with each other.

![](_page_5_Figure_7.jpeg)

## **Gain scanning (Critical gains)**

![](_page_6_Figure_1.jpeg)

## **Gain scanning (Buncher)**

■ It is clear to see the optimal gains (optimal KP and KI) of the buncher cavity according to the scanning map.

For the buncher cavity, the performance is dominated by the integral gains (KI) due to it is normal cavity (QL=2.1e4 [2]).

![](_page_7_Figure_3.jpeg)

## Gain scanning (Inj. 1)

The dominant gain in Inj1 is proportional gain (KP).

High gain controlling can be realized due to its narrow bandwidth.

![](_page_8_Figure_3.jpeg)

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δA/A [%.RMS]

## Gain scanning (Inj. 2&3)

![](_page_9_Figure_1.jpeg)

#### **Future Plan**

How to eliminate the 300 Hz fluctuation in the power supply (not by increasing the controlling gain but by hardware itself).

How to change the controlling parameter safely (KI, KP, SETA, SETP, etc.)? What is the limitation of every parameter?

■ Vector-sum controlling problem in the Inj. 2&3 (FB2).

#### Reference

[1] T. Miyajima, "Beam Commissioning of Energy Recovery Linacs", IPAC'13, Shanghai, May 2013, FRXBB201

[2] S. Sakanaka et al. "Progress in Construction of the 35-MeV Compact Energy Recovery Linac at KEK" IPAC'13, Shanghai, May 2013, WEPWA015

[3] F. QIU et al. "Evaluation of the Superconducting LLRF System at cERL in KEK". IPAC'13, Shanghai, May 2013, WEPEM015

#### **Question?**

#### Thank you very much for your attending

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## **Gain scanning (definition)**

- Gain scanning: determine the optimal controlling gains (@ 2MV foe security).
  Definition of the integral and proportional gains .
- I. FPGA input parameter *KP* and *KI*.
- II. Digital Gain *Kp* and *Ki*.
- III. Analog Gain *kp* and *ki*.
- IV. Real Gains: Aset/(Aset-Ameas.)

![](_page_13_Figure_6.jpeg)

Gains	Integral	Proportional
FPGA	KI	KP
Dig.	<i>Ki=KI</i> /2 <sup>18</sup>	$Kp = KP/2^{7}$
Ana.	$ki=Ki/T_{S}^{(1)}$	kp=Kp
Real	$\approx ki^*G_{op}^{(2)}$	$pprox kp^*G_{op}$

![](_page_13_Figure_8.jpeg)

ki&kp (ana.) vs. real gain Ased (Aset-Ameas.)

1 . $T_s$  is FPGA sampling clock period ( $T_s$ = 1/162.5e6 in cERL LLRF system)

2.  $G_{op}$  is the open-loop gain (Gains from FF to SEL(Fil) during the open-loop operation. For the Inj1 and Inj2&3,  $G_{op} \approx 1$  (0 dB).)

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#### Fluctuation at 300 Hz (Sim.)

![](_page_14_Figure_1.jpeg)

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#### Gain scanning (300 Hz Sim.)

![](_page_15_Figure_1.jpeg)

## Gain scanning (High Gain Sim.)

Too high gains would result of loop-unstable. We can evaluate the critical gain by both KI=0, KP gain-scanning and bode diagram simulation.

![](_page_16_Figure_2.jpeg)

## **Gain scanning (Performance)**

Gain-scanning experiment is implemented in 2MV/m condition, it is also in agreement well with 7 MV/m case.

Our requirement: 0.1% for amplitude, 0.1 deg for phase. <u>Satisfying (FB0&1&2)</u>.

![](_page_17_Figure_3.jpeg)